

20-BIT FET BUS SWITCH

2.5-V/3.3-V LOW-VOLTAGE BUS SWITCH WITH 5-V-TOLERANT LEVEL SHIFTER

Check for Samples: SN74CB3T16210

FEATURES

- Member of the Texas Instruments Widebus™ Family
- Output Voltage Translation Tracks V_{CC}
- Supports Mixed-Mode Signal Operation on All Data I/O Ports
 - 5-V Input Down to 3.3-V Output Level Shift With 3.3-V V_{CC}
 - 5-V/3.3-V Input Down to 2.5-V Output Level Shift With 2.5-V V_{CC}
- 5-V-Tolerant I/Os With Device Powered Up or **Powered Down**
- **Bidirectional Data Flow With Near-Zero** Propagation Delay
- Low ON-State Resistance (ron) Characteristics $(r_{on} = 5 \Omega Typ)$
- Low Input/Output Capacitance Minimizes Loading ($C_{io(OFF)} = 5 \text{ pF Typ}$)
- **Data and Control Inputs Provide Undershoot Clamp Diodes**
- Low Power Consumption $(I_{CC} = 40 \ \mu A \ Max)$
- V_{CC} Operating Range From 2.3 V to 3.6 V
- Data I/Os Support 0- to 5-V Signaling Levels • (0.8 V, 1.2 V, 1.5 V, 1.8 V, 2.5 V, 3.3 V, 5 V)
- Control Inputs Can Be Driven by TTL or 5-٠ V/3.3-V CMOS Outputs
- **I**off Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Performance Tested Per JESD 22
 - 2000-V Human-Body Model (A114-B, Class II)
 - 1000-V Charged-Device Model (C101)

DESCRIPTION/ORDERING INFORMATION

The SN74CB3T16210 is a high-speed TTL-compatible FET bus switch with low ON-state resistance (ron), allowing for minimal propagation delay. The device fully supports mixed-mode signal operation on all data I/O ports by providing voltage translation that tracks V_{CC} . The SN74CB3T16210 supports systems using 5-V TTL, 3.3-V LVTTL, and 2.5-V CMOS switching standards, as well as user-defined switching levels (see Figure 1).



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet. Widebus is a trademark of Texas Instruments.

- Supports Digital Applications: Level Translation, PCI Interface, USB Interface, Memory Interleaving, and Bus Isolation
 - Ideal for Low-Power Portable Equipment

DGG OR DGV PACKAGE (TOP VIEW)									
NC [1A1 [1A2 [1A3 [1A4 [1A5 [GND [1A7]	1 2 3 4 5 6 7 8 9	48 47 46 45 44 43 42 41 40]1 <u>0E</u>]2 <u>0E</u>]1B1]1B2]1B3]1B4]1B5]GND]1B6						
1A8 [1A9 [2A1 [2A2 [2A2 [2A3 [2A3 [2A4 [2A5 [2A5 [2A6 [2A7 [2A8 [2A9]	10 11 12 13 14 15 16 17 18 19 20 21 22 23	 39 38 37 36 35 34 33 32 31 30 29 28 27 26] 187] 188] 189] 1810] 281] 282] 283] 284] 285] 286] 287] 288] 289						
2A10	24	25	2B10						

NC - No internal connection



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DESCRIPTION/ORDERING INFORMATION (CONTINUED)

The SN74CB3T16210 is organized as two 10-bit bus switches with separate ouput-enable $(1\overline{OE}, 2\overline{OE})$ inputs. It can be used as two 10-bit bus switches or as one 20-bit bus switch. When \overline{OE} is low, the associated 10-bit bus switch is ON, and the A port is connected to the B port, allowing bidirectional data flow between ports. When \overline{OE} is high, the associated 10-bit bus switch is OFF, and a high-impedance state exists between the A and B ports.

This device is fully specified for partial-power-down applications using I_{off}. The I_{off} feature ensures that damaging current will not backflow through the device when it is powered down. The device has isolation during power off.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

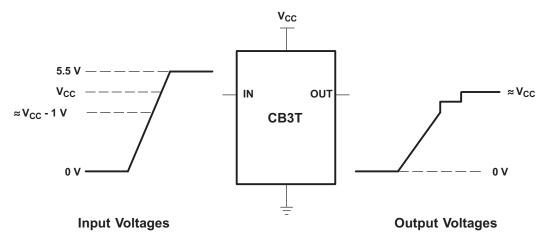
ORDERING INFORMATION

T _A	PACKAGE	(1)	ORDERABLE PART NUMBER	TOP-SIDE MARKING
40%C to 05%C	TSSOP – DGG	Tape and reel	SN74CB3T16210DGGR	CB3T16210
–40°C to 85°C	TVSOP – DGV	Tape and reel	SN74CB3T16210DGVR	KR210

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

(EACH 10-BIT BUS SWITCH)								
INPUT OE	INPUT/OUTPUT A	FUNCTION						
L	В	A port = B port						
н	Z	Disconnect						

FUNCTION TABLE



If the input high voltage (V_{H}) level is greater than or equal to V_{cc} + 1 V, and less than or equal to 5.5 V, the output high voltage (V_{OH}) level will be equal to approximately the V_{cc} voltage level.

Figure 1. Typical DC Voltage Translation Characteristics



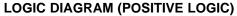
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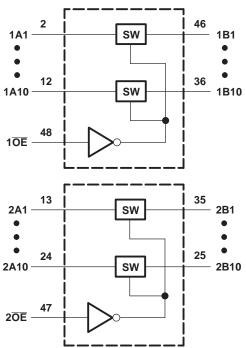
1 2 3 4 5 6
1 2 3 4 5 6
A 000000
BOCOCOC
c 000000
D 000000
E CC CC
F CC CC
G CCCCC
H CCCCCC
1 000000
K COCOCO

TERMINAL ASSIGNMENTS⁽¹⁾

	1	2	3	4	5	6
Α	1A2	1A1	NC	1 0E	2 <mark>0E</mark>	1B1
в	1A5	1A4	1A3	1B2	1B3	1B4
С	NC	GND	1A6	1B5	1B6	NC
D	1A8	NC	1A7	NC	1B7	1B8
Е	1A10	1A9			1B9	1B10
F	2A1	2A2			2B2	2B1
G	V _{CC}	GND	2A3	GND	2B4	2B3
н	NC	NC	2A4	2B5	NC	NC
J	2A5	2A6	2A7	2B7	2B6	2B5
κ	2A8	2A9	2A10	2B10	2B9	2B8

(1) NC - No internal connection



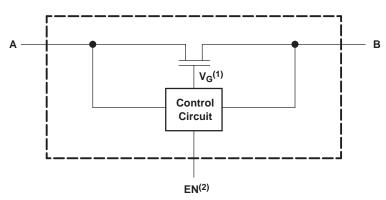


(AS STRUMENTS

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SIMPLIFIED SCHEMATIC, EACH FET SWITCH (SW)



(1) Gate voltage (V_G) is equal to approximately $V_{CC} + V_T$ when the switch is ON and $V_I > V_{CC} + V_T$. (2) EN is the internal enable signal applied to the switch.

Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

				MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	7	V	
V _{IN}	Control input voltage range ^{(2) (3)}			-0.5	7	V
V _{I/O}	Switch I/O voltage range ^{(2) (3) (4)}				7	V
I _{IK}	Control input clamp current	V _{IN} < 0			-50	mA
I _{I/OK}	I/O port clamp current	I/O port clamp current V _{I/O} < 0				mA
I _{IO}	ON-state switch current ⁽⁵⁾			±128	mA	
	Continuous current through V_{CC} or GND				±100	mA
0		DGG package			70	9 0 A M
θ_{JA}	Package thermal impedance ⁽⁶⁾	DGV package			58	°C/W
T _{stg}	Storage temperature range			-65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

All voltages are with respect to ground unless otherwise specified. (2)

(3) The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed. (4) V_I and V_O are used to denote specific conditions for $V_{I/O}$.

(5) I_{I} and I_{O} are used to denote specific conditions for $I_{I/O}$.

The package thermal impedance is calculated in accordance with JESD 51-7. (6)

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Recommended Operating Conditions⁽¹⁾

			MIN	MAX	UNIT		
V _{CC}	Supply voltage		2.3	3.6	V		
V _{IH}	Ligh lovel control input veltage	V_{CC} = 2.3 V to 2.7 V	1.7	5.5	V		
	High-level control input voltage	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2	5.5	V		
V	$V_{\rm CC} = 2.3$ V to 2.7		0	0.7			
VIL	Low-level control input voltage	0	0.8	V			
V _{I/O}	Data input/output voltage	a input/output voltage					
T _A	Operating free-air temperature	erature					

(1) All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

			T _A = -	40°C TO	85°C	UNIT		
PARAMETER		TEST CONDITIO	TEST CONDITIONS					
V _{IK}		V _{CC} = 3 V, I _I = -18 mA				-1.2	V	
V _{OH}		See Figure 3 and Figure 4						
I _{IN}	Control inputs	V_{CC} = 3.6 V, V_{IN} = 3.6 V to 5.5 V or GND				±10	μA	
		$V_{CC} = 3.6 V_{.}$	$V_{I} = V_{CC} - 0.7 \text{ V to } 5.5 \text{ V}$			±20		
l _l		Switch ON,	$V_{\rm I}$ = 0.7 V to $V_{\rm CC}$ – 0.7 V			-40	μA	
		$V_{IN} = V_{CC}$ or GND	$V_{I} = 0$ to 0.7 V			±5		
I_{OZ} ⁽³⁾		V_{CC} = 3.6 V, V_{O} = 0 to 5.5 V, V_{I} = 0, Switch O	FF, $V_{IN} = V_{CC}$ or GND			±10	μA	
I _{off}		$V_{CC} = 0, V_{O} = 0$ to 5.5 V, $V_{I} = 0$,				10	μA	
		$V_{CC} = 3.6 \text{ V}, \text{ I}_{I/O} = 0,$ $V_{I} = V_{CC} \text{ or GND}$				40		
I _{CC}		Switch ON or OFF, $V_{IN} = V_{CC}$ or GND	V_{CC} or GND $V_{I} = 5.5 V$			40	μA	
ΔI_{CC} ⁽⁴⁾	Control inputs	V_{CC} = 3 V to 3.6 V, One input at $V_{CC}~-$ 0.6 V	Other inputs at $V_{\mbox{\scriptsize CC}}$ or GND			300	μA	
C _{in}	Control inputs	V_{CC} = 3.3 V, V_{IN} = V_{CC} or GND			4		pF	
C _{io(OFF)}		V_{CC} = 3.3 V, $V_{I\!/\!O}$ = 5.5 V, 3.3 V, or GND, Swit	tch OFF, $V_{IN} = V_{CC}$ or GND		5		pF	
		$V_{CC} = 3.3 \text{ V}$, Switch ON, $V_{IN} = V_{CC}$ or GND	$V_{I/O} = 5.5 \text{ V or } 3.3 \text{ V}$		5		~ F	
C _{io(ON)}		$v_{CC} = 3.3 \text{ v}, \text{ Switch ON}, v_{IN} = v_{CC} \text{ of GND}$	$V_{I/O} = GND$		13		pF	
		$V_{CC} = 2.3 V. TYP$ at $V_{CC} = 2.5 V. V_{I} = 0$	I _O = 24 mA		5	9.5		
r _{on} ⁽⁵⁾		$v_{CC} = 2.5 v$, if r at $v_{CC} = 2.5 v$, $v_{l} = 0$	I _O = 16 mA		5	9.5	Ω	
'on `´		$V_{CC} = 3 V, V_1 = 0$	I _O = 64 mA		5	8.5		
		$v_{CC} = 0, v, v_{I} = 0$	I _O = 32 mA		5	8.5		

Electrical Characteristics⁽¹⁾

(1)

(2)

(3)

(4)

 V_{IN} and I_{IN} refer to control inputs. V_I , V_O , I_I , and I_O refer to data pins. All typical values are at $V_{CC} = 3.3$ V (unless otherwise noted), $T_A = 25^{\circ}$ C. For I/O ports, the parameter I_{OZ} includes the input leakage current. This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V_{CC} or GND. Measured by the voltage drop between A and B terminals at the indicated current through the switch. ON-state resistance is determined (5) by the lower of the voltages of the two (A or B) terminals.

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Switching Characteristics

for V_{CC} = 2.5 V \pm 0.2 V (see Figure 2)

PARAMETER		TO (OUTPUT)	V _{CC} = 2 ± 0.2	2.5 V 2 V	V _{CC} = 3 ± 0.3	3.3 V 8 V	UNIT
	(INPUT)	(001P01)	MIN	MAX	MIN	MAX	
t _{pd} ⁽¹⁾	A or B	B or A		0.15		0.25	ns
t _{en}	OE	A or B	1	12	1	10	ns
t _{dis}	ŌĒ	A or B	1	7.5	1	8.5	ns

(1) The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).

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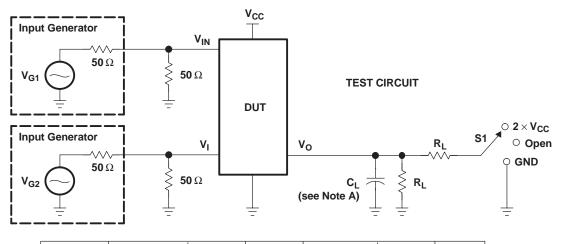
SN74CB3T16210



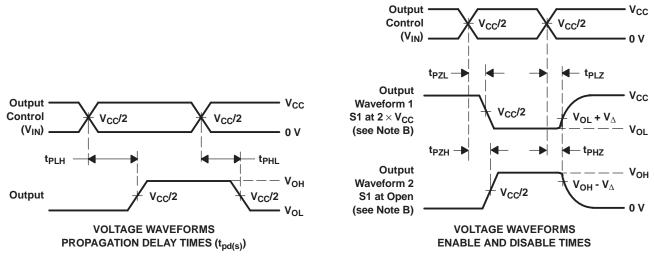
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PARAMETER MEASUREMENT INFORMATION



TEST	V _{CC}	S1	RL	VI	CL	V_{Δ}
t _{pd(s)}	2.5 V \pm 0.2 V	Open	500 Ω	3.6 V or GND	30 pF	
-pu(3)	3.3 V \pm 0.3 V	Open	500 Ω	5.5 V or GND	50 pF	
t _{PLZ} /t _{PZL}	2.5 V \pm 0.2 V	$2 \times V_{CC}$	500 Ω	GND	30 pF	0.15 V
PLZ PZL	3.3 V \pm 0.3 V	$2 \times V_{CC}$	500 Ω	GND	50 pF	0.3 V
t _{PHZ} /t _{PZH}	2.5 V \pm 0.2 V	Open	500 Ω	3.6 V	30 pF	0.15 V
'PHZ/'PZH	3.3 V \pm 0.3 V	Open	500 Ω	5.5 V	50 pF	0.3 V



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_r \leq 2.5 ns, t_f \leq 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. $t_{\text{PLZ}} \text{ and } t_{\text{PHZ}} \text{ are the same as } t_{\text{dis}}.$
- F. t_{PZL} and t_{PZH} are the same as $t_{\text{en}}.$
- G. t_{PLH} and t_{PHL} are the same as t_{pd(s)}. The tpd propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).
- H. All parameters and waveforms are not applicable to all devices.

Figure 2. Test Circuit and Voltage Waveforms

TYPICAL CHARACTERISTICS

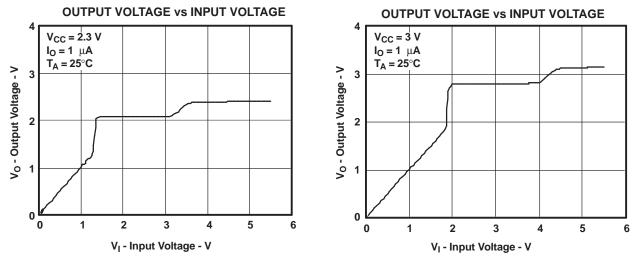
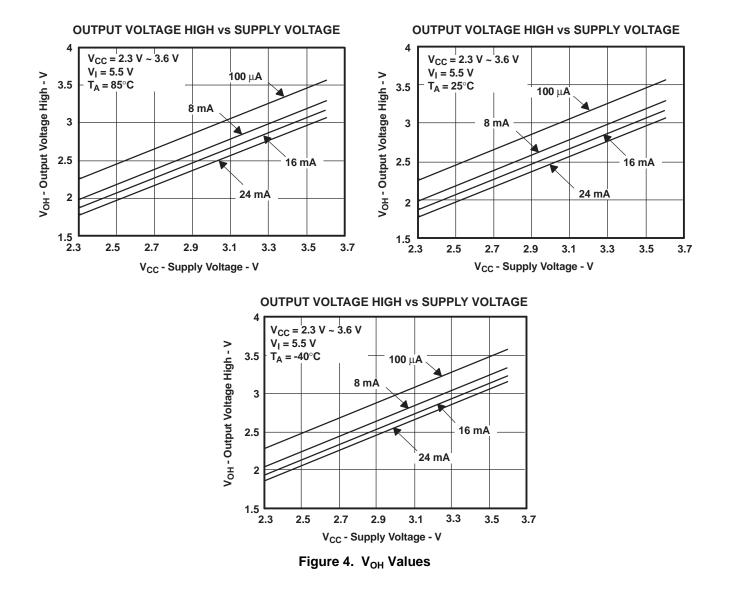


Figure 3. Data Output Voltage vs Data Input Voltage



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TYPICAL CHARACTERISTICS



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REVISION HISTORY

Changes from Revision A (March 2005) to Revision B							
•	Updated graphic note and picture in figure 1.		2				



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PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
74CB3T16210DGGRG4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CB3T16210	Samples
SN74CB3T16210DGG	PREVIEW	TSSOP	DGG	48	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CB3T16210	
SN74CB3T16210DGGR	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CB3T16210	Samples
SN74CB3T16210DGVR	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	KR210	Samples
SN74CB3T16210DL	PREVIEW	SSOP	DL	48	25	TBD	Call TI	Call TI	-40 to 85		
SN74CB3T16210DLR	PREVIEW	SSOP	DL	48	1000	TBD	Call TI	Call TI	-40 to 85		

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



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⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN74CB3T16210 :

Automotive: SN74CB3T16210-Q1

NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74CB3T16210DGGR	TSSOP	DGG	48	2000	330.0	24.4	8.6	13.0	1.8	12.0	24.0	Q1
SN74CB3T16210DGVR	TVSOP	DGV	48	2000	330.0	16.4	7.1	10.2	1.6	12.0	16.0	Q1

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74CB3T16210DGGR	TSSOP	DGG	48	2000	367.0	367.0	45.0
SN74CB3T16210DGVR	TVSOP	DGV	48	2000	367.0	367.0	38.0

MECHANICAL DATA

PLASTIC SMALL-OUTLINE

MPDS006C - FEBRUARY 1996 - REVISED AUGUST 2000

DGV (R-PDSO-G**)

24 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
- D. Falls within JEDEC: 24/48 Pins MO-153

14/16/20/56 Pins – MO-194



MECHANICAL DATA

MTSS003D - JANUARY 1995 - REVISED JANUARY 1998

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



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